	OLE E									
\$ 0 . 15 °					NOV 1 4 20	ល ទី	SHE	ET 1	OF 1	
Form PTO 1449 (Modified)		U.S. DEPARTMENT PATENT AND TRAI	OF COMMERCE DEMARK OFFICE	ATTY DOCKET NO. 197932US2RD			SERIAL NO. 09/671,012			
LIST OF	مدوور	RENCES CITED BY AP	APPLICANT							
LIST OF	KEFER	(ENCES CITED BY AL	PLICAITI	Keiichi TERAMO	GROUP					
				September 28, 2000			2661			
				U.S. PATENT DOCUM						
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	Ξ	CLASS	SUB CLASS		NG DATE PROPRIATE	
	AA					<u> </u>				
	AB						REC	FEIV	FD—	
-	AC AD		-	<del> </del>	<u></u>		NOV	1 7 20	103	
	AE		+	+		<del>                                     </del>	NOV			
	AF		1	<u> </u>	T		echnology Center 2600			
	AG									
	АН					ļ			,,,	
	Al			ļ		ļ				
	AJ			<u></u>		<del> </del>		<del> </del>		
-	AK AL		+	1			<del>                                     </del>	<del>                                     </del>	· · · · · · · · · · · · · · · · · · ·	
	AM		+	<del>                                     </del>		<del>                                     </del>		1		
	AN		+			1				
			. FC	DREIGN PATENT DOC	UMENTS					
	Γ	DOCUMENT		T				TRANSLATION		
		NUMBER	DATE		COUNTRY		YES		NO	
32	AO	10-154996	06/09/1998	JAPAN (with English					Х	
7,2	AP	10-164107	06/19/1998	JAPAN (with English			<u></u>		X	
38	AQ	8-116424	05/07/1996	JAPAN (with English	JAPAN (with English Abstract)				X	
	AR		<del></del>				<del>                                     </del>			
<del></del>	AS AT		<del></del>	<del>                                     </del>			<del>                                     </del>		7	
	AU	<del> </del>			<u> </u>		1			
	AV						<u> </u>			
		OTHER F	REFERENCES	(Including Author, Titl	e, Date, Pertinen	ıt Pages, e	etc.)			
	AW									
	AX									
	AY									
	AZ					Add	litional Ref	ferences sh	neet(s) attached	
Examiner	31	V. Q. Sa					onsidered	<u> </u>	reby	
*Examiner: I	nitial if r	reference is considered to considered. Include	<ol> <li>whether or no copy of this for</li> </ol>	ot citation is in conforma m with next communica	ance with MPEP 6 ition to applicant.	i09; Draw I	ine throug	h citation if	not in	

JUN 1 8 2003 JUN 1 8 2003

Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE			197932US2RD			SERIAL NO. 09/671,012					
				APPLICANT							
LIST OF	REFEF	RENCES CITED BY AP	PLICANT	Keiichi TERAMOTO, et al.							
				FILING DATE	GROUP						
				September 28, 2000	2661						
U.S. PATENT DOCUMENTS											
EXAMINER		DOCUMENT	σ.	_	CLASS	SUB	FII	ING DATE			
INITIAL		NUMBER	DATE	NAME	CLASS						
3.8	AA	5,764,699	06/09/98	M. L. NEEDHAM, et al.							
	AB										
	AC	· · · · · · · · · · · · · · · · · · ·			<u> </u>		-				
	AD										
	AE				ļ						
	AF				ļ		· · · · ·				
	AG				ļ						
	AH				RE						
	ΑI				.11 11.5			<i></i>			
	AJ				JU	N 1 9	2003				
	AK										
	AL				Techno	logy Co	nter 2	600			
	AM										
	AN										
			FO	REIGN PATENT DOCUMENTS			·				
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO						
92	AO	WO 95/35002	12/21/95	WIPO							
Z.E	AP	0 844 769	05/27/98	EUROPE							
	AQ										
	AR										
	AS										
,	AT		1								
	AU										
	ΑV										
	1	OTHER RE	FERENCES (	Including Author, Title, Date, Pertinen	t Pages, e	tc.)					
	AW										
	AX										
	AY										
	AZ				Addi	tional Refe	erences s	heet(s) attached			
Examiner	EU	and Se	5		Date Considered 03/20/04/			0/04/			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.											